TOSHIBA BIPOLAR DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62706P-H,TD62706FA-H

6CH HIGH-VOLTAGE SOURCE-CURRENT DRIVER

The TD62706P-H and TD62706FA-H are comprised of six source current Transistor Arrays.

These drivers are specifically designed for fluorescent display applications.

For proper operation, the substrate (SUB) must be connected to the most negative voltage.

Please observe the thermal condition for using.

FEATURES

• Package Type

P-H Type : DIP16pin

FA-H Type : SSOP16pin (1.0 mm pitch)

• High Output Voltage

: $V_{CC} - V_{OUT} = 60 \text{ V (MIN)}$

Output Current (Single Output)

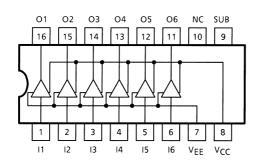
: $I_{OUT} = -50 \text{ mA (MAX)}$

• Input Compatible with Various Types of Logic

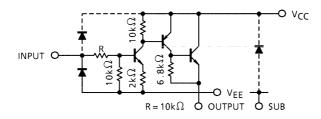
: RIN = $10 \text{ k}\Omega$

• Wide operating temperature range. : $T_{opr} = -40 \sim 105$ °C

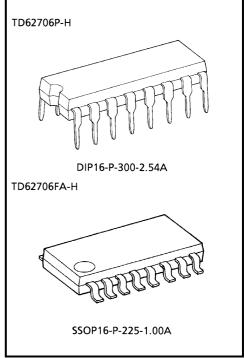
PIN ASSIGNMENT (Top view)



SCHEMATICS (Each driver)



Note: The input and output parasitic diodes cannot be used as clamp diodes.



Weight

DIP16-P-300-2.54A : 1.11 g (Typ.) SSOP16-P-225-1.00A : 0.14 g (Typ.)



MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Power Supply Voltage	V _{CC} -V _{EE}	30	V
Power Supply Voltage	V _{CC} -V _{SUB}	60	V
Output Voltage	V _{CC} -V _{OUT}	60	٧
Input Voltage	V _{IN} -V _{EE}	V _{CC} -V _{EE}	V
Output Current	lout	-50	mA / ch
Input Current	I _{IN}	±10	mA
Power Dissipation	P _D (Note 1)	1.0	W
Fower Dissipation	P _D (Note 2)	0.78	VV
Operating Temperature	T _{opr}	-40~105	°C
Storage Temperature	T _{stg}	-55~150	°C

Note 1: TD62706P-H : Delated above 25°C in the proportion of 8.0 mw / °C. Note 2: TD62706FA-H : On Glass Epoxy PCB ($50. \times 50 \times 1.6$ mm Cu 40%). Delated above 25°C in the proportion of 6.2 mw / °C.

RECOMMENDED OPERATING CONDITIONS (Ta = -40~85°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Power Supply Voltage	V _{CC}	V _{EE} = 0 V	4.5	_	25	V
Tower Supply Voltage	V _{SUB}	V _{CC} = 0 V	V _{OUT}	_	-55	V
Output Voltage	V _{OUT}	V _{CC} = 0 V	0	_	-55	٧
Output Current	I _{OUT}	_	0	_	-40	mA / ch
Input Voltage	V _{IN}	V _{EE} = 0 V, V _{CC} = 25 V	0	_	7	V
Power Dissipation	P _D	TD62706P-H	_	_	0.52	W
		TD62706FA-H when mounting	_	_	0.4	VV



ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARA	CTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN	TYP.	MA	UNIT
Input Voltage	"H" Level	V _{IH}	1	V _{EE} = 0 V	2.2	_	_	V
input voitage	"L" Level V _{IL} V _{EE} = 0 V	_	_	0.8	V			
Input Current	"H" Level	lін	2	V _{EE} = 0 V, V _{IN} = 2.4 V V _{EE} = V _{IN} = 0V, V _{CC} = 25 V	-	0.12	0.18	mA
Input Current	"L" Level	I _{IL}			_	_	±1	μΑ
Output Leakage	Current	ICEX	3	V _{EE} = 0 V, V _{CC} = 25 V V _{IN} = V _{IL MAX.} , V _{OUT} = -30 V	_	_	-100	μΑ
Collector-Emitte	r Saturation Voltage	V _{CE} (sat)	4	V _{EE} = 0 V, V _{CC} = V _{CC} MIN. V _{IN} = V _{IH} MIN. I _{OUT} = -40 mA	_	_	V _{CC} -2.5	V
Supply Current (Output On)	I _{CC (ON)}	1	V _{EE} = 0 V, V _{CC} = 25 V V _{IN} = V _{IH} MAX. OUTPUT = OPEN	_	_	25	mA
Turn-On Delay		t _{ON}	5	R _L = 1.4 kΩ	_	0.2	_	116
Turn-Off Delay		t _{OFF}] 3	C _L = 15 pF	_	1.5	_	μs

RECOMMENDED OPERATING CONDITIONS (Ta = -40\sim105°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION		MIN	TYP.	MAX	UNIT
Power Supply Voltage	V _{CC}	V _{EE} = 0 V	V _{EE} = 0 V			25	V
Tower Supply Voltage	V _{SUB}	V _{CC} = 0 V		V _{OUT}	_	-55	v
Output Voltage	V _{OUT}	V _{CC} = 0 V		0	_	-55	V
		2 Circuits Parallel ON	TD62706P-H	0	_	-40	-
	l _{OUT}		TD62706FA-H	0	_	-40	
		4 Circuits Parallel ON 6 Circuits Parallel ON	TD62706P-H	0	_	-37	mA /
Output Current			TD62706FA-H	0	_	-30	ch
			TD62706P-H	0	_	-15	
			TD62706FA-H	0	_	-25	
Input Voltage	V _{IN}	V _{EE} = 0 V, V _{CC} = 25 V		0	_	7	V
Power Dissipation	D _D	TD62706P-H		_	_	0.36	W
	P _D	TD62706FA-H when mounting		_	_	0.28	VV

3



ELECTRICAL CHARACTERISTICS (Ta = 105°C): TD62706P-H

CHARAG	CTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN	TYP.	MAX	UNIT
Input Voltage	"H" Level	V _{IH}	1	V _{EE} = 0 V	1.8	_	_	V
input voitage	"L" Level V _{IL} V _{EE} = 0 V	_	_	0.6	v			
Input Current	"H" Level	I _{IH}	2	V _{EE} = 0 V, V _{IN} = 2.4V	_	0.12	0.18	mA
input Current	"L" Level	I _{IL}	_	$V_{EE} = V_{IN} = 0 \text{ V}, V_{CC} = 25 \text{ V}$	_	_	±10	μA
Output Leakage	Current	ICEX	3	$V_{EE} = 0 \text{ V}, V_{CC} = 25 \text{ V}$ $V_{IN} = V_{IL} \text{ MAX.}$ $V_{OUT} = -30 \text{ V}$	_	_	-300	μА
Collector-Emitter	Saturation Voltage	V _{CE (sat)}	4	V _{EE} = 0 V, V _{CC} = V _{CC} MIN. V _{IN} = V _{IH} MIN. I _{OUT} = -40 mA	_	_	V _{CC} -2.5	V
Supply Current (C	Output On)	ICC (ON)	1	V _{EE} = 0 V, V _{CC} = 25 V V _{IN} = V _{IH} MAX. OUTPUT = OPEN	_	_	25	mA
Turn-On Delay		t _{ON}	5	$R_L = 1.4 \text{ k}\Omega$, Single circuit	_	0.4	_	116
Turn-Off Delay t_{OFF} $C_L = 15 pF$		C _L = 15 pF	_	3.0	_	μs		

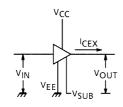
ELECTRICAL CHARACTERISTICS (Ta = 105°C): TD62706A-H

CHARA	CTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN	TYP.	MAX	UNIT
Input Voltage	"H" Level	V _{IH}	1	V _{EE} = 0 V	1.8	_	_	V
input voitage	"L" Level V_{IL} $V_{EE} = 0 V$	V _{EE} = 0 V	_	_	0.6	V		
Input Current	"H" Level	I _{IH}	2	V _{EE} = 0 V, V _{IN} = 2.4V	_	0.12	0.18	mA
Imput Current	"L" Level	I _{IL}		$V_{EE} = V_{IN} = 0 \text{ V}, V_{CC} = 25 \text{ V}$	_	_	±10	μΑ
Output Leakage	: Current	ICEX	3	V _{EE} = 0 V, V _{CC} = 25 V V _{IN} = V _{IL} MAX. V _{OUT} = -30 V	_	_	-300	μА
Collector-Emitter	Saturation Voltage	V _{CE} (sat)	4	V _{EE} = V _{SUB} = 0 V V _{CC} = V _{CC} MIN. V _{IN} = V _{IH} MIN. I _{OUT} = -25mA	-	_	V _{CC} -1.1	V
Supply Current (C	Output On)	I _{CC} (ON)	1	V _{EE} = V _{SUB} = 0 V V _{CC} = 16 V V _{IN} = V _{IH} MAX. OUTPUT = OPEN	_	_	10	mA
Turn-On Delay		t _{ON}	5	R_L = 1.4 kΩ, Single circuit	_	0.4	_	116
Turn-Off Delay		tOFF]	C _L = 15 pF	_	3.0	_	μs

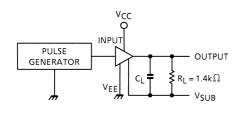
TEST CIRCUIT

1. VIH, VIL, ICC

3. I_{CEX}

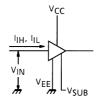


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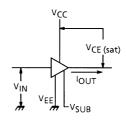


C_L = 15 pF (Includes probe and jig capacitance)

2. I_{IH}, I_{IL}



4. V_{CE (sat)}



Input condition

	V_{IN}	V_{CC}	V_{SUB}
TD62706	0 - 3 V	25 V	-30

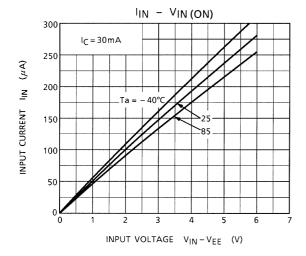
V_{IN}: Pulse Width 50 μ s
Duty Cycle 50% $t_r \le 5 \text{ ns}$ $t_f \le 10 \text{ ns}$

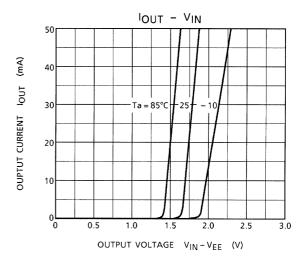
PRECAUTIONS for USING

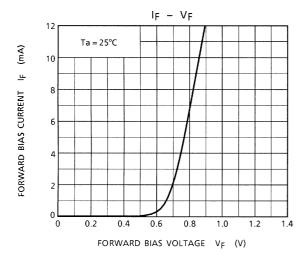
This IC does not integrate protection circuits such as overcurrent and overvoltage protectors.

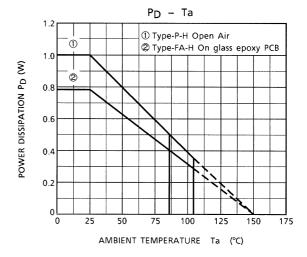
Thus, if excess current or voltage is applied to the IC, the IC may be damaged. Please design the IC so that excess current or voltage will not be applied to the IC.

Utmost care is necessary in the design of the output line, VCC and GND (SUB, VEE) line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

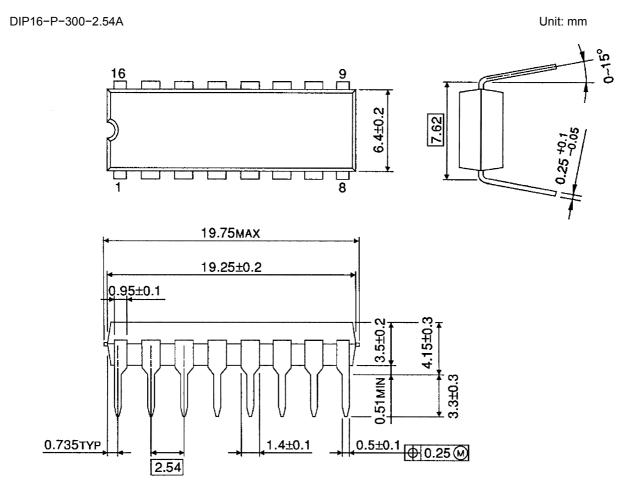








PACKAGE DIMENSIONS

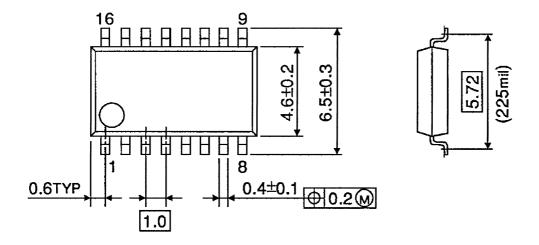


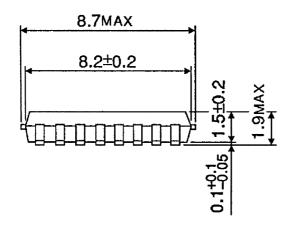
Weight: 1.11 g (Typ.)

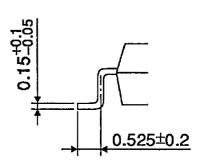
PACKAGE DIMENSIONS

SSOP16-P-225-1.00A

Unit: mm







Weight: 0.14 g (Typ.)

RESTRICTIONS ON PRODUCT USE

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